

- Depletion region ✓
- Breakdown ✓
- effect of temp
- diode models

Diode recap

pn Junction Diode Basic

majority: holes

p

majority: electrons

n

p n

] minority charge carriers depend only on temp, cuz electrons gain thermal energy and break covalent bonds

- The above p-type material is positive?
Do you agree? No, the atoms are neutral
- The above n-type material is negative?
Do you agree? No, p-type and n-type are neutral.
- Overall the pn-junction diode is charged and not neutral.
Do you agree? when put in a junction it is still electrically neutral

not on V applied

pn Junction Diode Basic (continued ...)

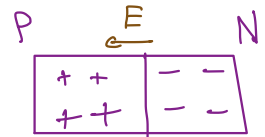
- Assume that a diode is virgin, which means it has never been connected to a power source after it was manufactured.

The above diagram represents such virgin diodes. Note that there is no depletion region.

Do you agree?

NO, there is a depletion region regardless of whether a bias is applied or not. Bias only affects size of depletion region

* Diffusion current due to majority charge carriers



there is a conc gradient.
-ve charges will diffuse to P side

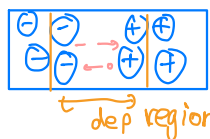
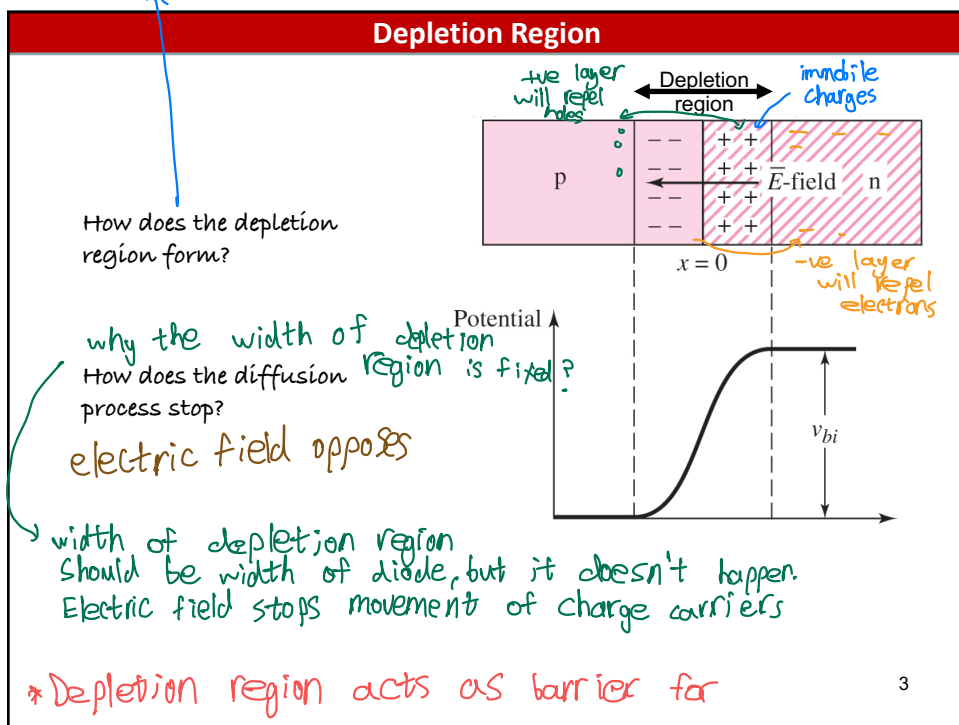
An electric field is set up.

Conc gradient fights with electric field, they oppose each other

Diffusion

- holes from p-side combines with electrons from n-side.
- As recombination takes place immobile ions will surface out (uncovering)

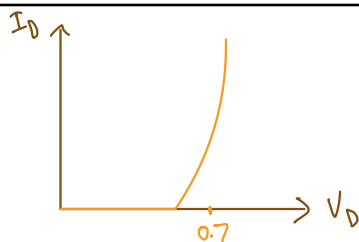
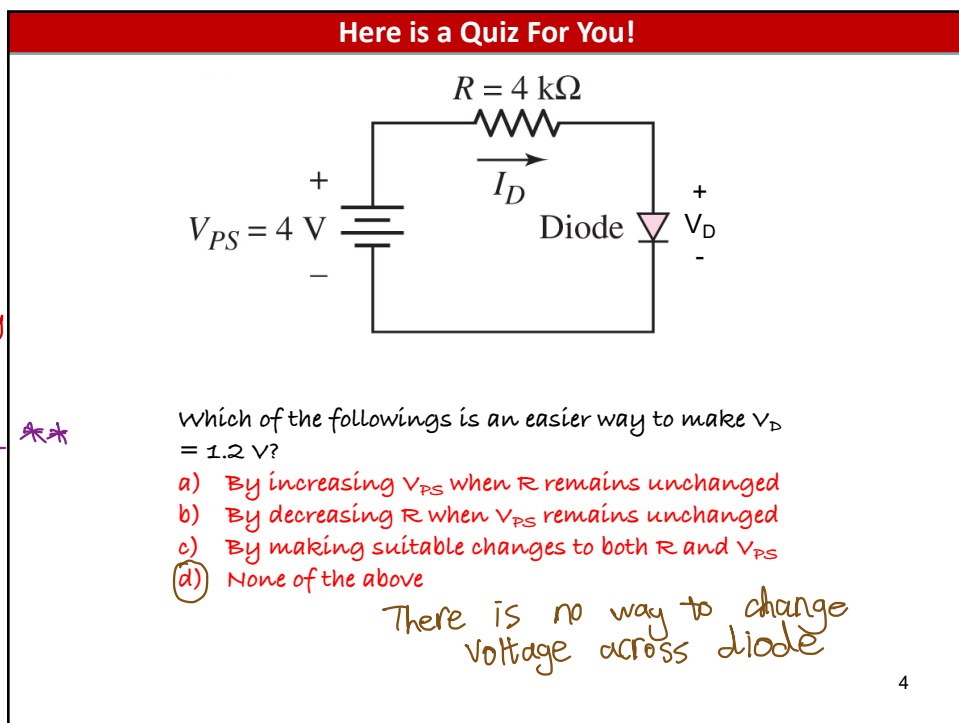
- Depletion region: no mobile charges but only uncovered immobile ion (depleted of mobile charges)



- movement of minority carriers makes drift current
- electrons drift to the layer
- drift current opposes diffusion current

drift: due to minority
diffusion: due to maj

**under steady state: **
diffusion = drift
net current = 0



- Electric field opposes diffusion and fixes width of depletion region
- electrons and holes have recombined in depletion region

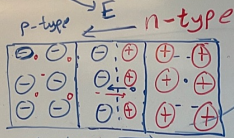
*note. that p-side and n-side are electrically neutral

PN junction

At zero bias

Diffusion = drift
current = current

Net current = 0



- *occurs due to conc gradient
- *-ve charges will diffuse to p-side
- *depletion region forms due to diffusion. it is an area with no free charges

- diffusion current due to majority

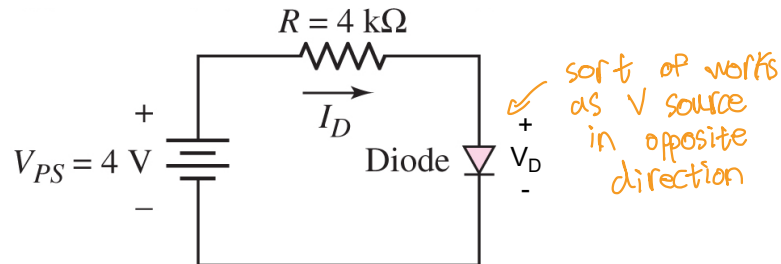
- drift current due to minority

*Current = movement of the charge
it's the flow from +ve to -ve

only affected by temp

BJT can be considered as a device with 2 diodes.
- one diode is biased by current of other diode

The Simplest Diode Circuit



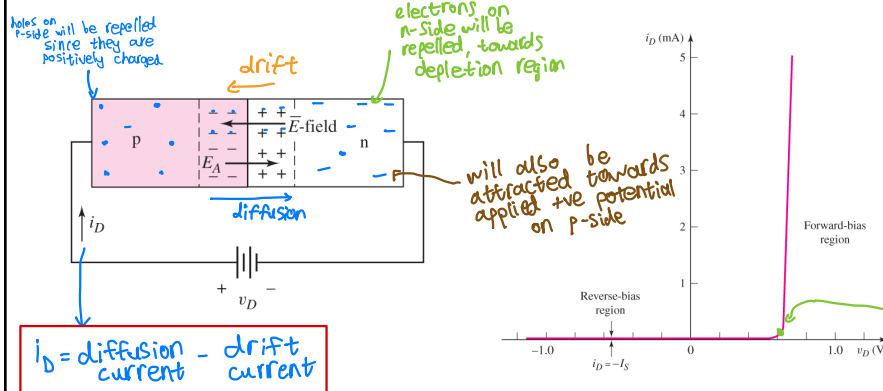
Determine I_D

$$V_R = 4 - 0.6 = 3.4 \text{ V}$$

$$I_D = 3.4 / 4 = 0.85 \text{ mA}$$

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Forward Biased pn Junction Diode



If the diode was made of a different material than Si, the cut-off voltage would still remain the same.

Do you agree?

- cut in voltage depends on material, so it will change

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- V_D forces majority free charge carriers to recombine and reduce width of depletion region

* holes combine with -ve ions
* electrons combine with +ve ions

→ depletion region has no mobile carriers, only immobile ions.

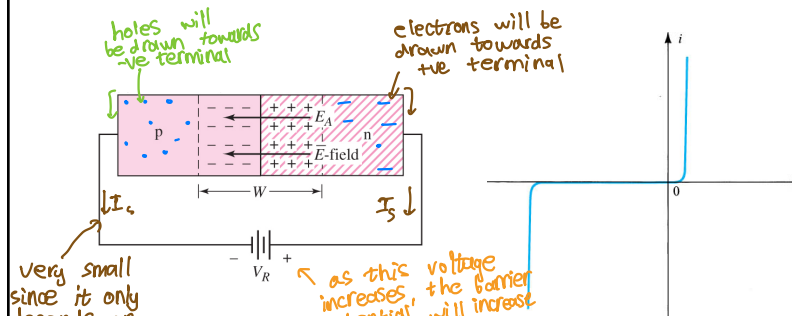
depletion region reduces
+ barrier potential reduces
↑
becomes
 $= V_B - V_D$

$$V_B = 0.7$$

As V_D reaches 0.7 barrier potential = 0

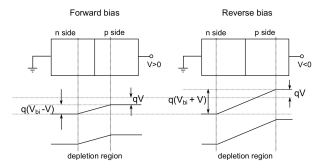
∴ Flood of electrons can now pass thru junction, resulting in exponential rise in i_D

Reverse Biased pn Junction Diode



Which of the following statements is correct for the depletion region width w for a given pn junction diode.

- a) $w_{(\text{Reverse bias})} > w_{(\text{forward bias})}$
 b) $w_{(\text{Reverse bias})} < w_{(\text{forward bias})}$
 c) $w_{(\text{Reverse bias})} = w_{(\text{forward bias})}$
 d) None of the above



built in barrier reduced, easier for current to flow

-low majority charge carriers can't cross junction.

Maj carrier = 0 flow

diffusion current reduces while drift current stays the same

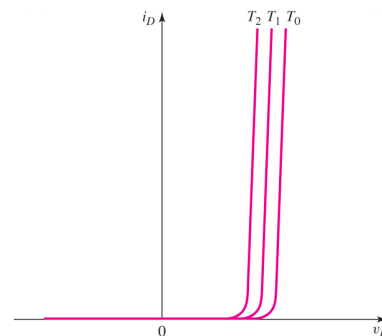
only affected by minority

depletion width:

reverse bias > no bias > fwd bias

barrier potential
reverse > no bias > fwd bias

Temperature Effect

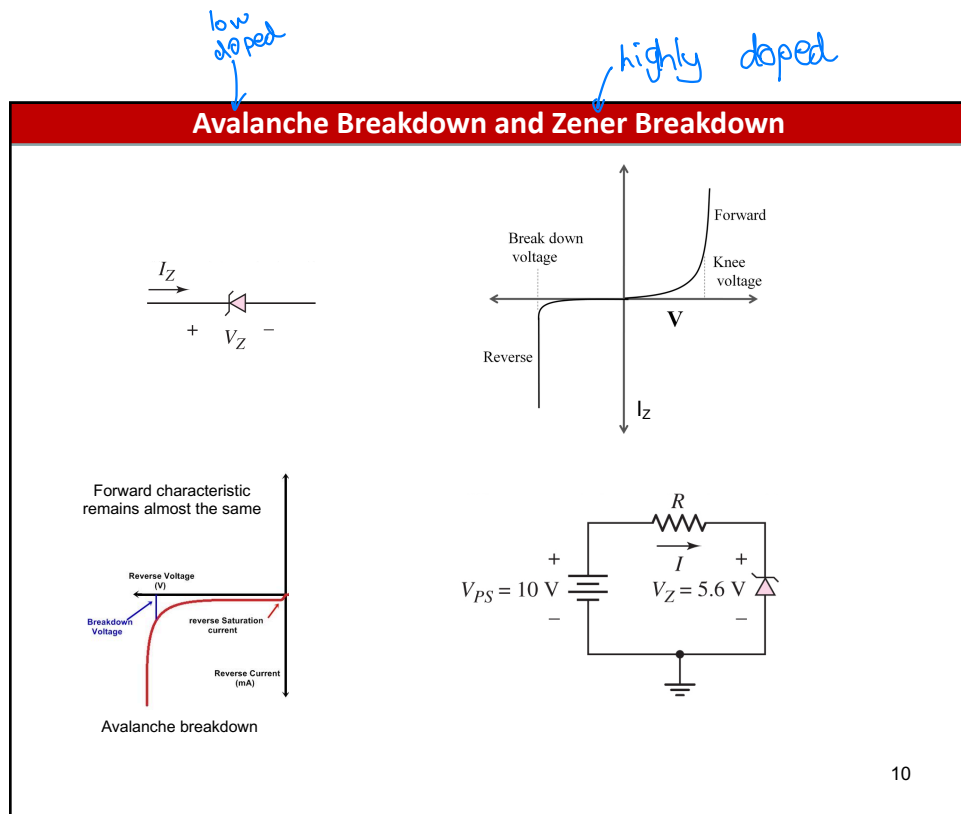
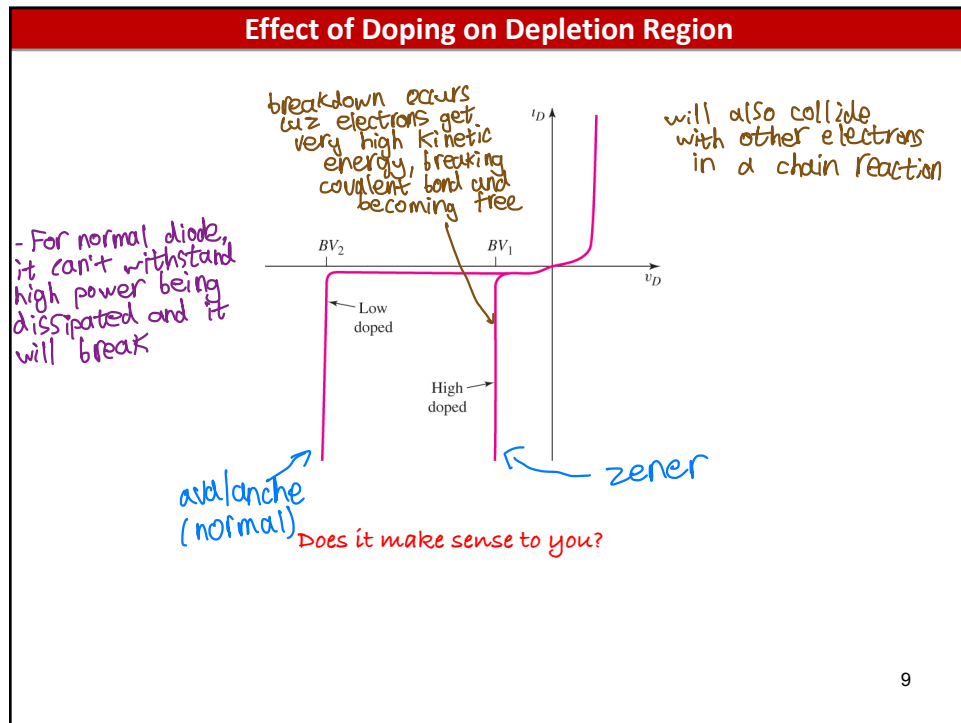


Which of the following statements is correct for the above characteristic curve of a forward biased diode?

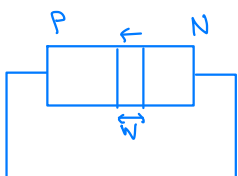
- a) $T_0 > T_1 > T_2$
 b) $T_0 < T_1 < T_2$

-heat gives it more free carriers, equal no. of holes and electrons are broken in the system

Temp ↑
min carriers ↑



* Do I need to know more on zener diodes??



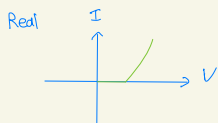
electric field only present within depletion region

$W = 10 \text{ mm}$

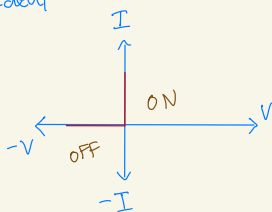
$V_{\text{Break}} = 10 \text{ V}$

$E = \frac{V}{d} = \frac{10 \times 10^6}{10}$

$= 1 \text{ MV/m} = 1 \text{ kV/mm}$



Ideal

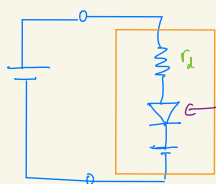
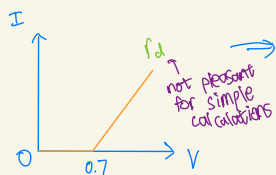


-acts like a perfect switch

$$V = 0_+, I = \infty$$

$$V = 0_-, I = 0$$

what we can model



ideal diode

*go over models again

another accepted model

